

GENERAL DESCRIPTION



The ICS8305 is a low skew, 1-to-4, Differential/LVCMOS-to-LVCMOS/LVTTL Fanout Buffer and a member of the HiPerClockS™ family of High Performance Clock Solutions from ICS. The ICS8305 has selectable clock inputs that accept either differen-

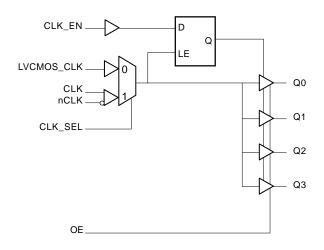
tial or single ended input levels. The clock enable is internally synchronized to eliminate runt pulses on the outputs during asynchronous assertion/deassertion of the clock enable pin. Outputs are forced LOW when the clock is disabled. A separate output enable pin controls whether the outputs are in the active or high impedance state.

Guaranteed output and part-to-part skew characteristics make the ICS8305 ideal for those applications demanding well defined performance and repeatability.

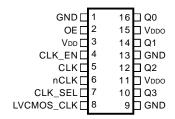
FEATURES

- 4 LVCMOS/LVTTL outputs
- Selectable differential or LVCMOS/LVTTL clock inputs
- CLK, nCLK pair can accept the following differential input levels: LVPECL, LVDS, LVHSTL, HCSL, SSTL
- LVCMOS_CLK supports the following input types: LVCMOS, LVTTL
- Maximum output frequency: 350MHz
- Output skew: 35ps (maximum)
- Part-to-part skew: 700ps (maximum)
- 3.3V core, 3.3V, 2.5V or 1.8V output operating supply
- 0°C to 70°C ambient operating temperature
- · Industrial temperature information available upon request

BLOCK DIAGRAM



PIN ASSIGNMENT



ICS8305

16-Lead TSSOP 4.4mm x 3.0mm x 0.92mm package body G Package Top View

LOW SKEW, 1-TO-4, MULTIPLEXED DIFFERENTIAL/LVCMOS-TO-LVCMOS/LVTTL FANOUT BUFFER

TABLE 1. PIN DESCRIPTIONS

Number	Name	Т	уре	Description
1, 9, 13	GND	Power		Power supply ground.
2	OE	Input	Pullup	Output enable. When LOW, outputs are in HIGH impedance state. When HIGH, outputs are active. LVCMOS / LVTTL interface levels.
3	$V_{_{\mathrm{DD}}}$	Power		Core supply pin.
4	CLK_EN	Input	Pullup	Synchronizing clock enable. When the clock is disabled, outputs are forced LOW. When clock is enabled, outputs are forced HIGH. LVCMOS / LVTTL interface levels.
5	CLK	Input	Pulldown	Non-inverting differential clock input.
6	nCLK	Input	Pullup/ Pulldown	Inverting differential clock input. V _{DD} /2 default when left floating.
7	CLK_SEL	Input	Pullup	Clock select input. When HIGH, selects CLK, nCLK inputs. When LOW, selects LVCMOS_CLK input. LVCMOS / LVTTL interface levels.
8	LVCMOS_CLK	Input	Pulldown	LVCMOS / LVTTL clock input.
10, 12, 14, 16	Q3, Q2, Q1, Q0	Output		Clock outputs. LVCMOS / LVTTL interface levels.
11, 15	$V_{\scriptscriptstyle DDO}$	Power		Output supply pins.

NOTE: Pullup and Pulldown refer to internal input resistors. See Table 2, Pin Characteristics, for typical values.

TABLE 2. PIN CHARACTERISTICS

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
C _{IN}	Input Capacitance			4		pF
R _{PULLUP}	Input Pullup Resistor			51		ΚΩ
R _{PULLDOWN}	Input Pulldown Resistor			51		ΚΩ
C _{PD}	Power Dissipation Capacitance (per output)			11		pF
R _{out}	Output Impedance			7		Ω

TABLE 3A. CONTROL INPUT FUNCTION TABLE

	Inputs					
OE	CLK_EN	CLK_SEL	Selected Source	Q0:Q3		
1	0	0	LVCMOS_CLK	Disabled; LOW		
1	0	1	CLK, nCLK	Disabled; LOW		
1	1	0	LVCMOS_CLK	Enabled		
1	1	1	CLK, nCLK	Enabled		
0	Х	Х		HiZ		

NOTE: After CLK_EN switches, the clock outputs are disabled or enabled following a rising and falling input clock edge as shown in Figure 1.

In the active mode, the state of the outputs are a function of the LVCMOS_CLK and CLK, nCLK inputs as described in Table 3B.

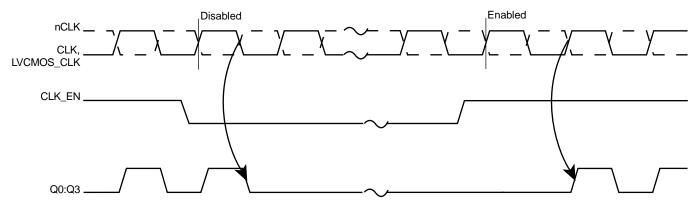


FIGURE 1. CLK_EN TIMING DIAGRAM

ABSOLUTE MAXIMUM RATINGS

Supply Voltage, V_{DD} 4.6V

Inputs, V_{ID} -0.5 V to V_{DD} + 0.5 V

Outputs, $V_{\rm DD}$ + 0.5V to $V_{\rm DD}$ + 0.5V

Package Thermal Impedance, θ_{IA} 89°C/W (0 Ifpm)

Storage Temperature, T_{STG} -65°C to 150°C

NOTE: Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the *DC Characteristics* or *AC Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

Table 4A. Power Supply DC Characteristics, $V_{DD} = 3.3V \pm 5\%$, $T_A = 0$ °C to 70°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V_{DD}	Core Supply Voltage		3.135	3.3	3.465	٧
			3.135	3.3	3.465	V
V_{DDO}	Output Supply Voltage		2.375	2.5	2.625	V
			1.65	1.8	1.95	V
I _{DD}	Power Supply Current				21	mA
I _{DDO}	Output Supply Current				5	mA

Table 4B. LVCMOS/LVTTL DC Characteristics, $V_{DD} = 3.3V \pm 5\%$, $T_A = 0$ °C to 70°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
V	Input	CLK_EN, CLK_SEL, OE		2		V _{DD} + 0.3	٧
V _{IH}	High Voltage	LVCMOS_CLK		2		V _{DD} + 0.3	V
V	Input	CLK_EN, CLK_SEL, OE		-0.3		0.8	V
V _{IL}	Low Voltage	LVCMOS_CLK		-0.3		1.3	V
	Input	CLK_EN, CLK_SEL, OE	$V_{DD} = V_{IN} = 3.465V$			5	μA
¹IH	High Current	LVCMOS_CLK	$V_{DD} = V_{IN} = 3.465V$			150	μA
1	Input	CLK_EN, CLK_SEL, OE	$V_{DD} = 3.465 \text{V}, \ V_{IN} = 0 \text{V}$	-150			μΑ
I	Low Current	LVCMOS_CLK	$V_{DD} = 3.465 \text{V}, \ V_{IN} = 0 \text{V}$	-5			μΑ
			$V_{DDO} = 3.3V \pm 5\%$	2.6			V
V _{OH}	Output High V	oltage; NOTE 1	$V_{DDO} = 2.5V \pm 5\%$	1.8			V
			$V_{DDO} = 1.8V \pm 0.15V$	1.5			V
			$V_{DDO} = 3.3V \pm 5\%$			0.5	V
V _{OL}	Output Low Vo	oltage; NOTE 1	$V_{DDO} = 2.5V \pm 5\%$			0.5	V
			$V_{DDO} = 1.8V \pm 0.15V$			0.4	V
I _{OZL}	Output Tristate	e Current Low		-5			μΑ
I _{OZH}	Output Tristate	e Current High				5	μA

NOTE 1: Outputs terminated with 50 Ω to $V_{DDO}/2$. See Parameter Measurement Information, Output Load Test Circuit.



LOW SKEW, 1-TO-4, MULTIPLEXED DIFFERENTIAL/LVCMOS-TO-LVCMOS/LVTTL FANOUT BUFFER

Table 4C. Differential DC Characteristics, $V_{DD} = 3.3V \pm 5\%$, $T_A = 0^{\circ}C$ to $70^{\circ}C$

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
	Input High Current	nCLK	$V_{IN} = V_{DD} = 3.465V$			150	μA
I'IH		CLK	$V_{IN} = V_{DD} = 3.465V$			150	μA
	Input Low Current	nCLK	$V_{IN} = 0V, V_{DD} = 3.465V$	-150			μA
I _{IL}	Imput Low Current	CLK	$V_{IN} = 0V, V_{DD} = 3.465V$	-5			μA
V _{PP}	Peak-to-Peak Input Voltage			0.15		1.3	V
V _{CMR}	Common Mode Input Voltage; NOTE 1, 2			GND + 0.5		V _{DD} - 0.85	V

NOTE 1: For single ended applications, the maximum input voltage for CLK, nCLK is $V_{\tiny DD}$ + 0.3V.

NOTE 2: Common mode voltage is defined as V_{III}.

Table 5A. AC Characteristics, $V_{DD} = V_{DDO} = 3.3V \pm 5\%$, Ta = 0°C to 70°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
f _{MAX}	Output Frequency					350	MHz
tp _{LH}	Propagation Delay, Low to High	LVCMOS_CLK; NOTE 1A CLK, nCLK; NOTE 1B		1.75		2.75	ns
tsk(o)	Output Skew; NOTE 2, 5		Measured on the Rising Edge			35	ps
tsk(pp)	Part-to-Part Skew; N	NOTE 3, 5				700	ps
t _R / t _F	Output Rise/Fall Tim	ne; NOTE 4	20% to 80%	100		700	ps
			Ref = CLK/nCLK	45		55	%
odc	Output Duty Cycle		$Ref = LVCMOS_CLK, \\ f \le 300MHz$	45		55	%
t _{EN}	Output Enable Time; NOTE 4					5	ns
t _{DIS}	Output Disable Time	e; NOTE 4				5	ns

All parameters measured at $f \le 350 \text{MHz}$ unless noted otherwise.

NOTE 1A: Measured from the $V_{\rm DD}/2$ of the input to $V_{\rm DDO}/2$ of the output.

NOTE 1B: Measured from the differential input crossing point to V_{DDO}/2 of the output.

NOTE 2: Defined as skew between outputs at the same supply voltage and with equal load conditions.

Measured at V_{DDO}/2.

NOTE 3: Defined as skew between outputs on different devices operating a the same supply voltages and with equal load conditions. Using the same type of input on each device, the output is measured at $V_{ppo}/2$.

NOTE 4: These parameters are guaranteed by characterization. Not tested in production.

NOTE 5: This parameter is defined in accordance with JEDEC Standard 65.



Table 5B. AC Characteristics, $V_{DD} = 3.3V \pm 5\%$, $V_{DDO} = 2.5V \pm 5\%$, Ta = 0°C to 70°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
f _{MAX}	Output Frequency					350	MHz
tp _{LH}	Propagation Delay, Low to High	LVCMOS_CLK; NOTE 1A CLK, nCLK; NOTE 1B		1.8		2.9	ns
tsk(o)	Output Skew; NOTE 2, 5		Measured on the Rising Edge			35	ps
tsk(pp)	Part-to-Part Skew; NOTE 3, 5					800	ps
t_R/t_F	Output Rise/Fall Tim	ne; NOTE 4	20% to 80%	100		700	ps
			Ref = CLK/nCLK	44		56	%
odc	Output Duty Cycle		$Ref = LVCMOS_CLK, \\ f \le 300MHz$	44		56	%
t _{EN}	Output Enable Time; NOTE 4					5	ns
t _{DIS}	Output Disable Time	e; NOTE 4				5	ns

All parameters measured at $f \le 350 \text{MHz}$ unless noted otherwise.

NOTE 1A: Measured from the $V_{\rm DD}/2$ of the input to $V_{\rm DDO}/2$ of the output.

NOTE 1B: Measured from the differential input crossing point to V_{DDO}/2 of the output.

NOTE 2: Defined as skew between outputs at the same supply voltage and with equal load conditions. Measured at V_{ppo}/2.

NOTE 3: Defined as skew between outputs on different devices operating a the same supply voltages and

with equal load conditions. Using the same type of input on each device, the output is measured at V_{ppq}/2.

NOTE 4: These parameters are guaranteed by characterization. Not tested in production.

NOTE 5: This parameter is defined in accordance with JEDEC Standard 65.

Table 5C. AC Characteristics, $V_{DD} = 3.3V \pm 5\%$, $V_{DDO} = 1.8V \pm -0.15V$, Ta = 0°C to 70°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
f _{MAX}	Output Frequency					350	MHz
tp _{LH}	Propagation Delay, Low to High	LVCMOS_CLK; NOTE 1A CLK, nCLK; NOTE 1B		1.95		3.65	ns
tsk(o)	Output Skew; NOTE 2, 5		Measured on the Rising Edge			35	ps
tsk(pp)	Part-to-Part Skew; NOTE 3, 5					900	ps
t _R / t _F	Output Rise/Fall Tim	ne; NOTE 4	20% to 80%	100		700	ps
			Ref = CLK/nCLK	44		56	%
odc	Output Duty Cycle		$Ref = LVCMOS_CLK, \\ f \le 300MHz$	44		56	%
t _{EN}	Output Enable Time; NOTE 4					5	ns
t _{DIS}	Output Disable Time	e; NOTE 4				5	ns

All parameters measured at $f \le 350 \text{MHz}$ unless noted otherwise.

NOTE 1A: Measured from the $V_{pp}/2$ of the input to $V_{ppo}/2$ of the output.

NOTE 1B: Measured from the differential input crossing point to V_{ppo}/2 of the output.

NOTE 2: Defined as skew between outputs at the same supply voltage and with equal load conditions. Measured at V_{ppg}/2.

NOTE 3: Defined as skew between outputs on different devices operating a the same supply voltages and

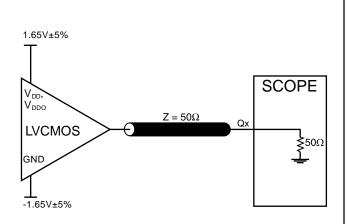
with equal load conditions. Using the same type of input on each device, the output is measured at $V_{ppq}/2$.

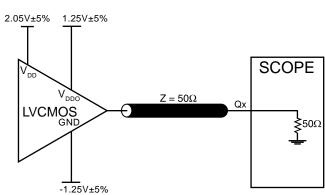
NOTE 4: These parameters are guaranteed by characterization. Not tested in production.

NOTE 5: This parameter is defined in accordance with JEDEC Standard 65.



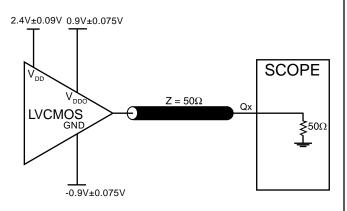
PARAMETER MEASUREMENT INFORMATION

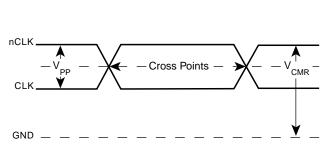




3.3V Core/3.3V OUTPUT LOAD AC TEST CIRCUIT

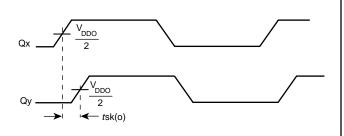
3.3V CORE/2.5V OUTPUT LOAD AC TEST CIRCUIT

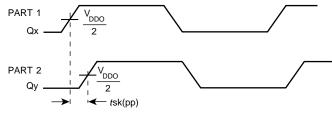




3.3V Core/1.8V OUTPUT LOAD AC TEST CIRCUIT

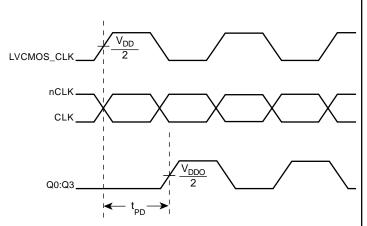
DIFFERENTIAL INPUT LEVEL

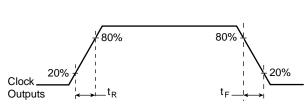




OUTPUT SKEW

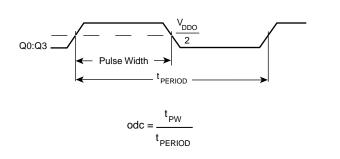
PART-TO-PART SKEW





PROPAGATION DELAY

OUTPUT RISE/FALL TIME



odc & t_{PERIOD}

8

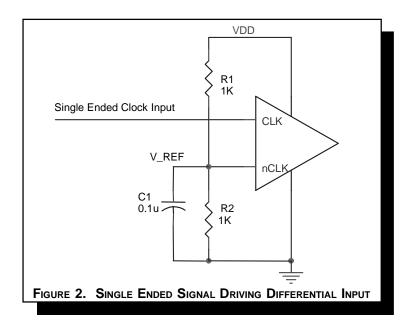


APPLICATION INFORMATION

WIRING THE DIFFERENTIAL INPUT TO ACCEPT SINGLE ENDED LEVELS

Figure 2 shows how the differential input can be wired to accept single ended levels. The reference voltage $V_REF = V_{DD}/2$ is generated by the bias resistors R1, R2 and C1. This bias circuit should be located as close as possible to the input pin. The ratio

of R1 and R2 might need to be adjusted to position the V_REF in the center of the input voltage swing. For example, if the input clock swing is only 2.5V and $V_{\rm DD}$ = 3.3V, V_REF should be 1.25V and R2/R1 = 0.609.



DIFFERENTIAL CLOCK INPUT INTERFACE

The CLK/nCLK accepts LVDS, LVPECL, LVHSTL, SSTL, HCSL and other differential signals. Both V_{SWING} and V_{OH} must meet the V_{PP} and V_{CMR} input requirements. Figures 3A to 3E show interface examples for the HiPerClockS CLK/nCLK input driven by the most common driver types. The input interfaces suggested

here are examples only. Please consult with the vendor of the driver component to confirm the driver termination requirements. For example in *Figure 3A*, the input termination applies for ICS HiPerClockS LVHSTL drivers. If you are using an LVHSTL driver from another vendor, use their termination recommendation.

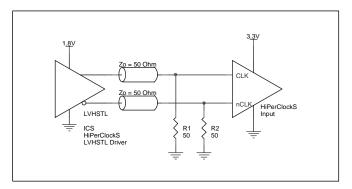


FIGURE 3A. HIPERCLOCKS CLK/NCLK INPUT DRIVEN BY ICS HIPERCLOCKS LVHSTL DRIVER

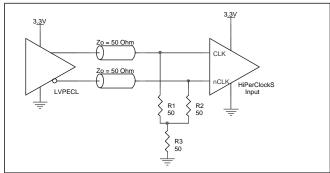


FIGURE 3B. HIPERCLOCKS CLK/NCLK INPUT DRIVEN BY 3.3V LVPECL DRIVER

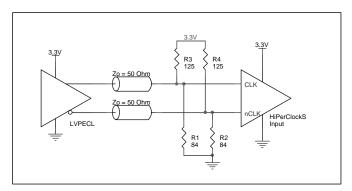


FIGURE 3C. HIPERCLOCKS CLK/NCLK INPUT DRIVEN BY 3.3V LVPECL DRIVER

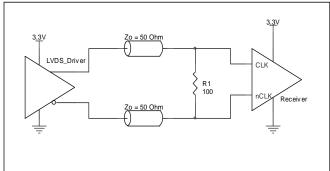


FIGURE 3D. HIPERCLOCKS CLK/NCLK INPUT DRIVEN BY 3.3V LVDS DRIVER

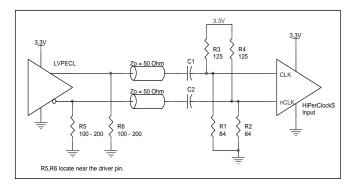


FIGURE 3E. HIPERCLOCKS CLK/NCLK INPUT DRIVEN BY 3.3V LVPECL DRIVER WITH AC COUPLE

SCHEMATIC EXAMPLE

This application note provides general design guide using ICS8305 LVCMOS buffer. *Figure 3* shows a schematic example of the ICS8305 LVCMOS clock buffer. In this example, the input

is driven by an LVCMOS driver. CLK_EN is set at logic low to select LVCMOS_CLK input.

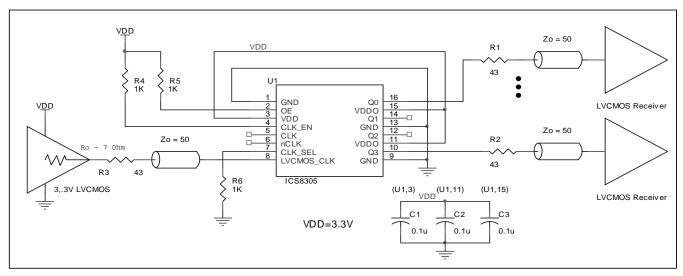


FIGURE 4. EXAMPLE ICS8305 LVCMOS CLOCK OUTPUT BUFFER SCHEMATIC

RELIABILITY INFORMATION

Table 6. $\theta_{\text{JA}} \text{vs. A} \text{ir Flow Table}$

$\boldsymbol{\theta}_{\text{JA}}$ by Velocity (Linear Feet per Minute)

0200500Single-Layer PCB, JEDEC Standard Test Boards137.1°C/W118.2°C/W106.8°C/WMulti-Layer PCB, JEDEC Standard Test Boards89.0°C/W81.8°C/W78.1°C/W

NOTE: Most modern PCB designs use multi-layered boards. The data in the second row pertains to most designs.

TRANSISTOR COUNT

The transistor count for ICS8305 is: 459

PACKAGE OUTLINE - G SUFFIX

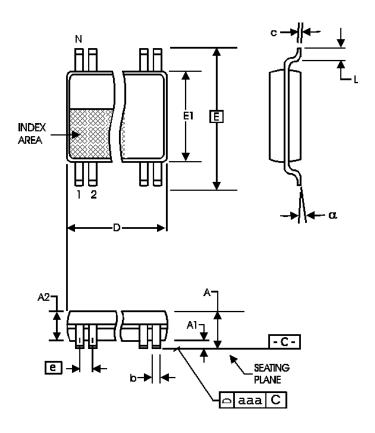


TABLE 7. PACKAGE DIMENSIONS

SYMBOL	Millin	neters		
STWIBOL	Minimum	Maximum		
N	16			
Α		1.20		
A1	0.05	0.15		
A2	0.80	1.05		
b	0.19	0.30		
С	0.09	0.20		
D	4.90	5.10		
E	6.40 E	BASIC		
E1	4.30	4.50		
е	0.65 E	BASIC		
L	0.45	0.75		
α	0°	8°		
aaa		0.10		

Reference Document: JEDEC Publication 95, MO-153

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TABLE 8. ORDERING INFORMATION

Part/Order Number	Marking	Package	Count	Temperature
ICS8305AG	ICS8305AG	16 Lead TSSOP	94 per tube	0°C to 70°C
ICS88305AGT	ICS8305AG	16 Lead TSSOP on Tape and Reel	2500	0°C to 70°C

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